

# BYV32E-200

Dual rugged ultrafast rectifier diode, 20 A, 200 V

Rev. 04 — 27 February 2009

Product data sheet

## 1. Product profile

### 1.1 General description

Ultrafast dual epitaxial rectifier diode in a SOT78 (TO-220AB) plastic package.

### 1.2 Features and benefits

- High reverse voltage surge capability
- High thermal cycling performance
- Low thermal resistance
- Soft recovery characteristic minimizes power consuming oscillations
- Very low on-state loss

### 1.3 Applications

- Output rectifiers in high-frequency switched-mode power supplies

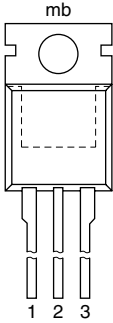
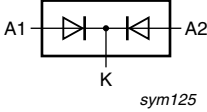
### 1.4 Quick reference data

Table 1. Quick reference

| Symbol                         | Parameter                       | Conditions  | Min | Typ  | Max  | Unit |
|--------------------------------|---------------------------------|---|-----|------|------|------|
| $V_{RRM}$                      | repetitive peak reverse voltage |   | -   | -    | 200  | V    |
| $I_{O(AV)}$                    | average output current          | square-wave pulse; $\delta = 0.5$ ; $T_{mb} \leq 115\text{ °C}$ ; both diodes conducting; see <a href="#">Figure 1</a> ; see <a href="#">Figure 2</a> | -   | -    | 20   | A    |
| $I_{RRM}$                      | repetitive peak reverse current | $t_p = 2\ \mu\text{s}$ ; $\delta = 0.001$   | -   | -    | 0.2  | A    |
| $V_{ESD}$                      | electrostatic discharge voltage | HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins  | -   | -    | 8    | kV   |
| <b>Dynamic characteristics</b> |                                 |   |     |      |      |      |
| $t_{rr}$                       | reverse recovery time           | $I_F = 1\text{ A}$ ; $V_R = 30\text{ V}$ ; $dI_F/dt = 100\text{ A}/\mu\text{s}$ ; $T_j = 25\text{ °C}$ ; ramp recovery; see <a href="#">Figure 5</a>  | -   | 20   | 25   | ns   |
|                                |                                 | $I_R = 1\text{ A}$ ; $I_F = 0.5\text{ A}$ ; $T_j = 25\text{ °C}$ ; step recovery; measured at reverse current = 0.25 A; see <a href="#">Figure 6</a>  | -   | 10   | 20   | ns   |
| <b>Static characteristics</b>  |                                 |   |     |      |      |      |
| $V_F$                          | forward voltage                 | $I_F = 8\text{ A}$ ; $T_j = 150\text{ °C}$ ; see <a href="#">Figure 4</a>   | -   | 0.72 | 0.85 | V    |

## 2. Pinning information

**Table 2. Pinning information**

| Pin | Symbol | Description            | Simplified outline   | Graphic symbol  |
|-----|--------|------------------------|--|---|
| 1   | A1     | anode 1                |  |  |
| 2   | K      | cathode                |  |   |
| 3   | A2     | anode 2                |  |   |
| mb  | K      | mounting base; cathode |  |   |

**SOT78**  
(TO-220AB; SC-46)

## 3. Ordering information

**Table 3. Ordering information**

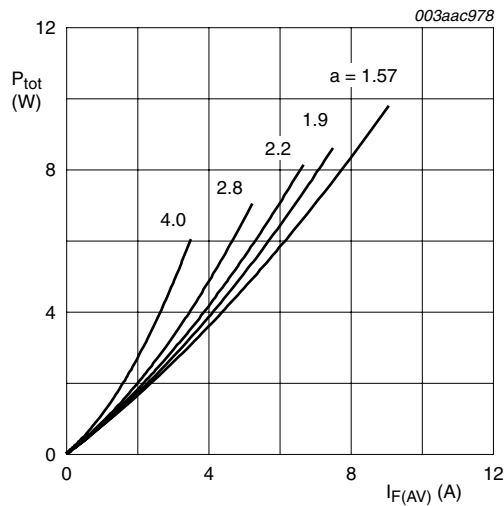
| Type number | Package   |   | Version |
|-------------|-----------|---|---------|
|             | Name      | Description   |         |
| BYV32E-200  | TO-220AB; | plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead | SOT78   |
|             | SC-46     |   |         |

### 4. Limiting values

**Table 4. Limiting values**

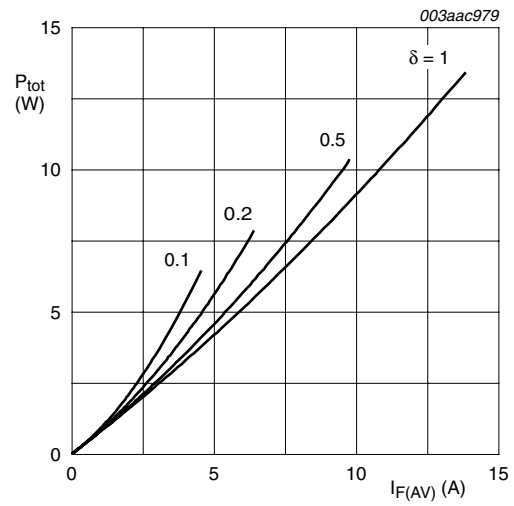
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol      | Parameter                           | Conditions  | Min | Max | Unit             |
|-------------|-------------------------------------|---|-----|-----|------------------|
| $V_{RRM}$   | repetitive peak reverse voltage     |   | -   | 200 | V                |
| $V_{RWM}$   | crest working reverse voltage       |   | -   | 200 | V                |
| $V_R$       | reverse voltage                     | DC  | -   | 200 | V                |
| $I_{O(AV)}$ | average output current              | square-wave pulse; $\delta = 0.5$ ; $T_{mb} \leq 115\text{ }^\circ\text{C}$ ; both diodes conducting; see <a href="#">Figure 1</a> ; see <a href="#">Figure 2</a> | -   | 20  | A                |
| $I_{FRM}$   | repetitive peak forward current     | $\delta = 0.5$ ; $t_p = 25\text{ }\mu\text{s}$ ; $T_{mb} \leq 115\text{ }^\circ\text{C}$ ; per diode  | -   | 20  | A                |
| $I_{FSM}$   | non-repetitive peak forward current | $t_p = 8.3\text{ ms}$ ; sine-wave pulse; $T_{j(\text{init})} = 25\text{ }^\circ\text{C}$ ; per diode  | -   | 137 | A                |
|             |                                     | $t_p = 10\text{ ms}$ ; sine-wave pulse; $T_{j(\text{init})} = 25\text{ }^\circ\text{C}$ ; per diode   | -   | 125 | A                |
| $I_{RRM}$   | repetitive peak reverse current     | $\delta = 0.001$ ; $t_p = 2\text{ }\mu\text{s}$   | -   | 0.2 | A                |
| $I_{RSM}$   | non-repetitive peak reverse current | $t_p = 100\text{ }\mu\text{s}$  | -   | 0.2 | A                |
| $T_{stg}$   | storage temperature                 |   | -40 | 150 | $^\circ\text{C}$ |
| $T_j$       | junction temperature                |   | -   | 150 | $^\circ\text{C}$ |
| $V_{ESD}$   | electrostatic discharge voltage     | HBM; C = 250 pF; R = 1.5 k $\Omega$ ; all pins  | -   | 8   | kV               |



$$a = \text{form factor} = I_{F(RMS)} / I_{F(AV)}$$

**Fig 1. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values**



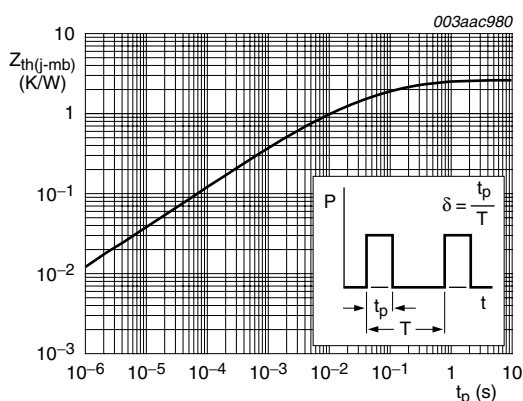
$$I_{F(AV)} = I_{F(RMS)} \times \sqrt{\delta}$$

**Fig 2. Forward power dissipation as a function of average forward current; square waveform; maximum values**

## 5. Thermal characteristics

**Table 5. Thermal characteristics**

| Symbol         | Parameter   | Conditions  | Min | Typ | Max | Unit |
|----------------|---|---|-----|-----|-----|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | with heatsink compound; both diodes conducting                  | -   | -   | 1.6 | K/W  |
|                |   | with heatsink compound; per diode; see <a href="#">Figure 3</a> | -   | -   | 2.4 | K/W  |
| $R_{th(j-a)}$  | thermal resistance from junction to ambient       |   | -   | 60  | -   | K/W  |

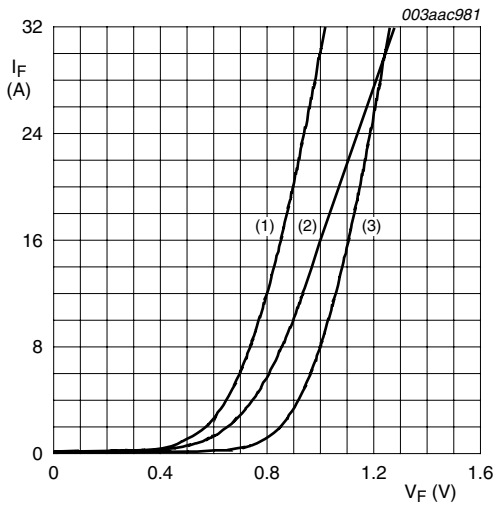


**Fig 3. Transient thermal impedance from junction to mounting base as a function of pulse width**

## 6. Characteristics

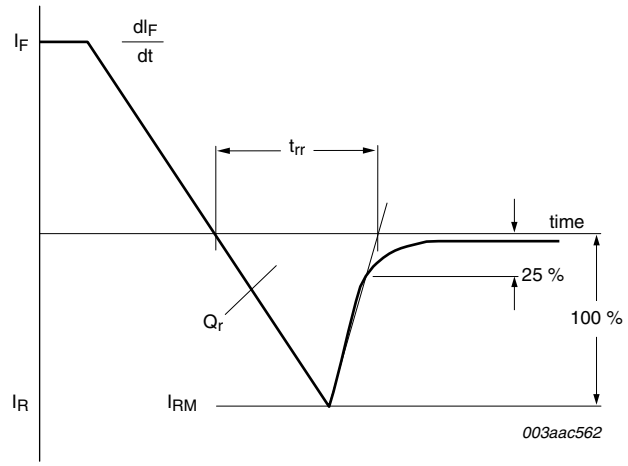
**Table 6. Characteristics**

| Symbol                         | Parameter                | Conditions   | Min | Typ  | Max  | Unit          |
|--------------------------------|--------------------------|--|-----|------|------|---------------|
| <b>Static characteristics</b>  |                          |  |     |      |      |               |
| $V_F$                          | forward voltage          | $I_F = 20\text{ A}; T_j = 25\text{ °C}$  | -   | 1    | 1.15 | V             |
|                                |                          | $I_F = 8\text{ A}; T_j = 150\text{ °C}$ ; see <a href="#">Figure 4</a>   | -   | 0.72 | 0.85 | V             |
| $I_R$                          | reverse current          | $V_R = 200\text{ V}; T_j = 100\text{ °C}$  | -   | 0.2  | 0.6  | mA            |
|                                |                          | $V_R = 200\text{ V}; T_j = 25\text{ °C}$   | -   | 6    | 30   | $\mu\text{A}$ |
| <b>Dynamic characteristics</b> |                          |  |     |      |      |               |
| $Q_r$                          | recovered charge         | $I_F = 2\text{ A}; V_R = 30\text{ V}; di_F/dt = 20\text{ A}/\mu\text{s}; T_j = 25\text{ °C}$   | -   | 8    | 12.5 | nC            |
| $t_{rr}$                       | reverse recovery time    | $I_F = 1\text{ A}; V_R = 30\text{ V}; di_F/dt = 100\text{ A}/\mu\text{s};$ ramp recovery; $T_j = 25\text{ °C}$ ; see <a href="#">Figure 5</a>    | -   | 20   | 25   | ns            |
|                                |                          | $I_F = 0.5\text{ A}; I_R = 1\text{ A};$ step recovery; measured at reverse current = 0.25 A; $T_j = 25\text{ °C}$ ; see <a href="#">Figure 6</a> | -   | 10   | 20   | ns            |
| $V_{FR}$                       | forward recovery voltage | $I_F = 1\text{ A}; di_F/dt = 10\text{ A}/\mu\text{s}; T_j = 25\text{ °C}$ ; see <a href="#">Figure 7</a>   | -   | -    | 1    | V             |

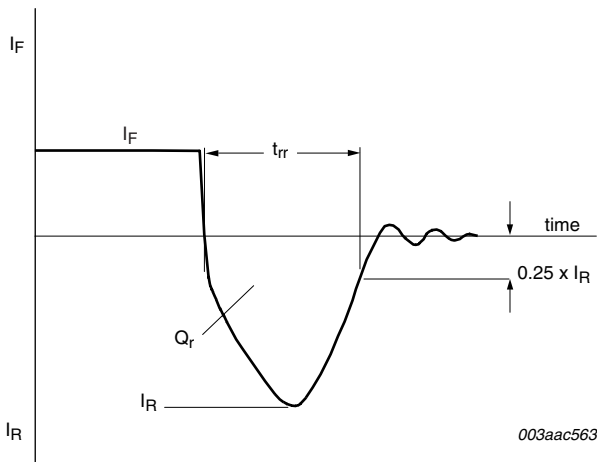


- (1)  $T_j = 150\text{ }^\circ\text{C}$ ; typical values
- (2)  $T_j = 150\text{ }^\circ\text{C}$ ; maximum values
- (3)  $T_j = 25\text{ }^\circ\text{C}$ ; maximum values

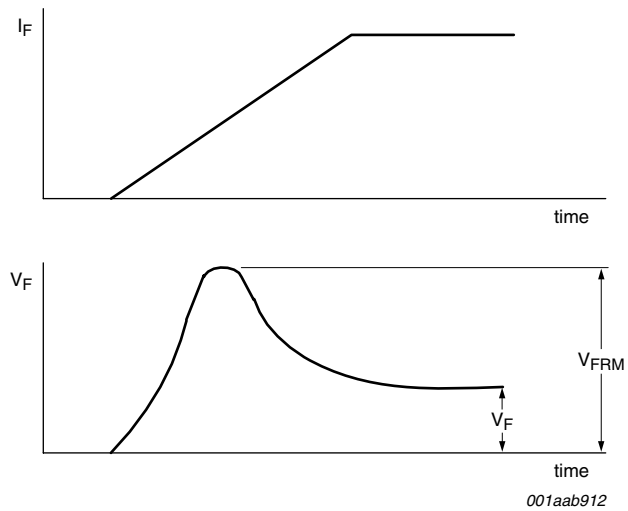
**Fig 4. Forward current as a function of forward voltage**



**Fig 5. Reverse recovery definitions; ramp recovery**



**Fig 6. Reverse recovery definitions; step recovery**



**Fig 7. Forward recovery definitions**

7. Package outline

Plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB

SOT78

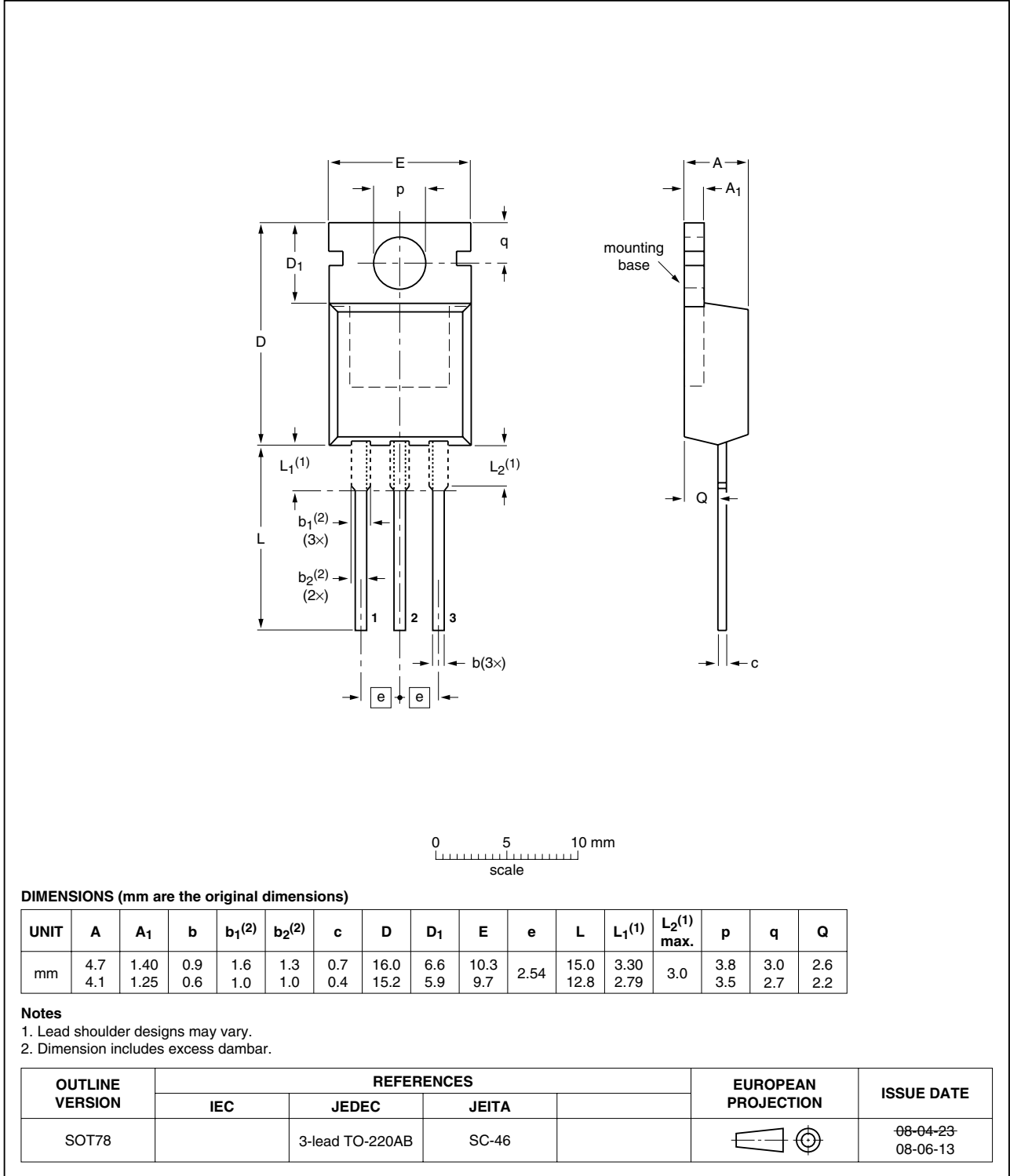


Fig 8. Package outline SOT78 (TO-220AB)

## 8. Revision history

**Table 7.** Revision history

| Document ID      | Release date | Data sheet status   | Change notice | Supersedes       |
|------------------|--------------|---|---------------|------------------|
| BYV32E-200_4     | 20090227     | Product data sheet  | -             | BYV32E_SERIES_3  |
| Modifications:   |              | <ul style="list-style-type: none"> <li>• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>• Legal texts have been adapted to the new company name where appropriate.</li> <li>• Package outline updated.</li> <li>• Type number BYV32E-200 separated from data sheet BYV32E_SERIES_3</li> </ul> |               |                  |
| BYV32E_SERIES_3  | 20010301     | Product specification   | -             | BYV32E_SERIES_2  |
| BYV32E_SERIES_2  | 19980701     | Product specification   | -             | BYV32EB_SERIES_1 |
| BYV32EB_SERIES_1 | 19960801     | Product specification   | -             | -                |

## 9. Legal information

### 9.1 Data sheet status

| Document status <sup>[1][2]</sup> | Product status <sup>[3]</sup> | Definition  |
|-----------------------------------|-------------------------------|---|
| Objective [short] data sheet      | Development                   | This document contains data from the objective specification for product development. |
| Preliminary [short] data sheet    | Qualification                 | This document contains data from the preliminary specification.                       |
| Product [short] data sheet        | Production                    | This document contains the product specification.                                     |

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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**11. Contents**

**1 Product profile . . . . .1**

1.1 General description . . . . .1

1.2 Features and benefits . . . . .1

1.3 Applications . . . . .1

1.4 Quick reference data . . . . .1

**2 Pinning information . . . . .2**

**3 Ordering information . . . . .2**

**4 Limiting values . . . . .3**

**5 Thermal characteristics . . . . .4**

**6 Characteristics . . . . .4**

**7 Package outline . . . . .6**

**8 Revision history . . . . .7**

**9 Legal information . . . . .8**

9.1 Data sheet status . . . . .8

9.2 Definitions . . . . .8

9.3 Disclaimers . . . . .8

9.4 Trademarks . . . . .8

**10 Contact information . . . . .8**

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Date of release: 27 February 2009

Document identifier: BYV32E-200\_4